











SLLS408H – JANUARY 2000 – REVISED OCTOBER 2016

**MAX3222** 

# MAX3222 3-V to 5.5-V Multichannel RS-232 Line Driver and Receiver With ±15-kV ESD Protection

#### 1 Features

- RS-232 Bus-Pin ESD Protection Exceeds ±15 kV Using Human-Body Model (HBM)
- Meets or Exceeds the Requirements of TIA/EIA-232-F and ITU v.28 Standards
- Operates With 3-V to 5.5-V V<sub>CC</sub> Supply
- Operates Up to 250 kbps
- · Two Drivers and Two Receivers
- Low Standby Current: 1 µA Typical
- External Capacitors: 4 x 0.1 μF
- Accepts 5-V Logic Input With 3.3-V Supply
- Alternative High-Speed Pin-Compatible Device (1 Mbps)
  - SNx5C3222

## 2 Applications

- · Battery-Powered Systems
- PDAs
- Notebooks
- Laptops
- Palmtop PCs
- · Hand-held Equipment

## 3 Description

The MAX3222 consists of two line drivers, two line receivers, and a dual charge-pump circuit with ±15-kV ESD protection pin to pin (serial-port connection pins, including GND). The device meets the requirements of TIA/EIA-232-F and provides the electrical interface between an asynchronous communication controller and the serial-port connector. The charge pump and four small external capacitors allow operation from a single 3-V to 5.5-V supply. The device operates at data signaling rates up to 250 kbit/s and a maximum of 30-V/µs driver output slew rate.

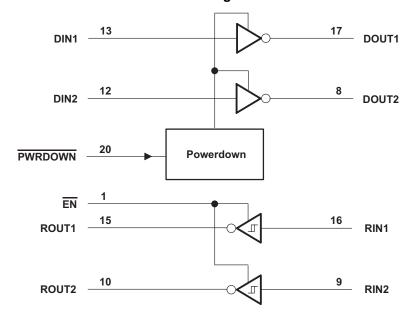
The MAX3222 <u>can be placed</u> in the power-down mode by setting PWRDOWN low, which draws only 1  $\mu$ A from the power supply. When the device is powered down, the receivers remain active while the drivers are placed in the high-impedance state. Receiver outputs also can be placed in the high-impedance state by setting EN high.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
MAX3222CDW, MAX322IDW	SOIC (20)	12.80 mm × 7.50 mm
MAX3222CDB, MAX322IDB	SSOP (20)	7.20 mm × 5.30 mm
MAX3222CPW, MAX322IPW	TSSOP (20)	6.50 mm × 4.40 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

#### **Block Diagram**





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## 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

#### Changes from Revision G (March 2004) to Revision H

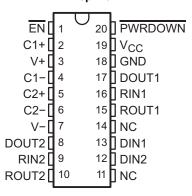
Page

Added ESD Ratings table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section.
 Deleted ODERING INFORMATION table; see POA at the end of the datasheet.
 Changed R<sub>0JA</sub> for DB, DW and PW package from: 70 °C/W to 84.4°C/W (DB), 58 °C/W to 70.2 °C/W (DW) and 83



## 5 Pin Configuration and Functions

DB, DW, or PW Package 20-Pin SOIC, SSOP, TSSOP Top View



NC - No internal connection

#### **Pin Functions**

P	IN		DECODINE COLUMN
NAME	NO.	I/O	DESCRIPTION
C1+	2	_	Charge pump capacitor pin
C1-	4	_	Charge pump capacitor pin
C2+	5	_	Charge pump capacitor pin
C2-	6	_	Charge pump capacitor pin
DIN1	13	I	Driver logic input
DIN2	12	1	Driver logic input
DOUT1	17	0	RS-232 driver output
DOUT2	8	0	RS-232 driver output
EN	1	1	Receiver enable, active low
GND	18	_	Ground
NC	11,14	_	No internal connection
PWRDOWN	20	I	Driver disable, active low
RIN1	16	I	RS-232 receiver input
RIN2	9	1	RS-232 receiver input
ROUT1	15	0	Receiver logic output
ROUT2	10	0	Receiver logic output
V <sub>CC</sub>	19	_	Power Supply
V+	3	_	Charge pump capacitor pin
V-	7	_	Charge pump capacitor pin



## **Specifications**

#### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

		MIN	MAX	UNIT
Supply voltage, V <sub>CC</sub> <sup>(2)</sup>		-0.3	6	V
Positive output supply voltage, V+	(2)	-0.3	7	V
Negative output supply voltage, V-	_(2)	0.3	-7	V
Supply voltage difference, V+ - V-	-		13	V
Input voltage V	Drivers, EN, PWRDOWN	-0.3	6	V
Input voltage, V <sub>I</sub>	Receiver	-25	25	V
Output valtage V	Drivers	-13.2	13.2	V
Output voltage, V <sub>O</sub>	Receivers	-0.3	$V_{CC} + 0.3$	V
Operating virtual junction temperat	ure, T <sub>J</sub>		150	°C
Storage temperature, T <sub>stg</sub>		-65	150	°C

Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## 6.2 ESD Ratings

				VALUE	UNIT
		Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001	Pins 8, 9, 16, 17 and 18	±15000	
V <sub>(ESD)</sub>	Electrostatic discharge	RIN, DOUT, and GND pins <sup>(1)</sup>	All other pins	±3000	V
	districtings	Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	All pins	±1500	

JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

#### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>. See Figure 8.

				MIN	NOM	MAX	UNIT
	Cupply voltogo	V <sub>CC</sub> = 3.3 V		3	3.3	3.6	V
	Supply voltage	$V_{CC} = 5 V$		4.5	5	5.5	V
VIH	Driver and control high-level	DIR, EN, PWRDOWN	V <sub>CC</sub> = 3.3 V	2			_ v
VIII	input voltage	DIR, EN, PWRDOWN	$V_{CC} = 5 V$	2.4			
VIL	Driver and control low-level input voltage	DIR, EN, PWRDOWN				0.8	V
VI	Driver and control input voltage	DIR, EN, PWRDOWN		0		5.5	V
VI	Receiver input voltage			-25		25	V
Τ.	Th. 0 11 1 11	MAX3222C		0		70	°C
TA	Operating free-air temperature	MAX3222I		-40		85	<b>℃</b>

(1) Test conditions are C1-C4 = 0.1  $\mu$ F at  $V_{CC}$  = 3.3 V  $\pm$  0.3 V; C1 = 0.047  $\mu$ F, C2-C4 = 0.33  $\mu$ F at  $V_{CC}$  = 5 V  $\pm$  0.5 V.

All voltages are with respect to network GND.



#### 6.4 Thermal Information

			MAX3222				
THERMAL METRIC <sup>(1)(2)(3)</sup>		DB (SSOP)	DW (SOIC)	PW (TSSOP)	UNIT		
		20 PINS	20 PINS	20 PINS			
$R_{\theta JA}$	Junction-to-ambient thermal resistance	84.4	70.2	94.3	°C/W		
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	44.1	36.2	29.9	°C/W		
$R_{\theta JB}$	Junction-to-board thermal resistance	40	37.9	45.1	°C/W		
ΨЈТ	Junction-to-top characterization parameter	11	11.1	1.4	°C/W		
ΨЈВ	Junction-to-board characterization parameter	39.5	37.5	44.6	°C/W		

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application

#### 6.5 Electrical Characteristics: Device

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>. See Figure 8.

	PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(2)</sup>	MAX	UNIT
II	Input leakage current (EN, PWRDOWN)			±0.01	±1	μΑ
	Supply current	No load, PWRDOWN at V <sub>CC</sub>		0.3	1	mA
ICC	Supply current (powered off)	No load, PWRDOWN at GND		1	10	μA

Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V  $\pm$  0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V  $\pm$  0.5 V. All typical values are at V<sub>CC</sub> = 3.3 V or V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C.

#### 6.6 Electrical Characteristics: Driver

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>. See Figure 8.

	PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(2)</sup>	MAX	UNIT
V <sub>OH</sub>	High-level output voltage	DOUT at $R_L = 3 \text{ k}\Omega$ to GND, DIN = GND	5	5.4		V
V <sub>OL</sub>	Low-level output voltage	DOUT at $R_L = 3 \text{ k}\Omega$ to GND, DIN = $V_{CC}$	-5	-5.4		V
I <sub>IH</sub>	High-level input current	$V_I = V_{CC}$		±0.01	±1	μΑ
I <sub>IL</sub>	Low-level input current	V <sub>I</sub> at GND		±0.01	±1	μΑ
I <sub>OS</sub>	Short-circuit output current	$V_{CC} = 3.6 \text{ V}, V_{O} = 0 \text{ V}$ $V_{CC} = 5.5 \text{ V}, V_{O} = 0 \text{ V}$		±35	±60	mA
r <sub>o</sub>	Output resistance	$V_{CC}$ , V+, and V- = 0 V, $V_{O}$ = ±2 V	300	10M		Ω
	Output lockage current	$\overline{PWRDOWN} = GND, V_O = \pm 12 V,$ $V_{CC} = 3 V \text{ to } 3.6 V$			±25	
I <sub>off</sub>	Output leakage current	$\overline{\text{PWRDOWN}} = \text{GND, V}_{\text{O}} = \pm 10 \text{ V},$ $\text{V}_{\text{CC}} = 4.5 \text{ V to } 5.5 \text{ V}$			±25	μΑ

Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V ± 0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V ± 0.5 V. All typical values are at V<sub>CC</sub> = 3.3 V or V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C.

Maximum power dissipation is a function of  $T_{J(max)}$ ,  $\theta_{JA}$ , and  $T_A$ . The maximum allowable power dissipation at any allowable ambient temperature is  $P_D = (T_{J(max)} - T_A)/\theta_{JA}$ . Operating at the absolute maximum  $T_J$  of 150°C can affect reliability. The package thermal impedance is calculated in accordance with JESD 51-7.



#### 6.7 Electrical Characteristics: Receiver

over operating free-air temperature range (unless otherwise noted)(1). See Figure 8.

	PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(2)</sup>	MAX	UNIT
V <sub>OH</sub>	High-level output voltage	I <sub>OH</sub> = -1 mA	V <sub>CC</sub> - 0.6	V <sub>CC</sub> - 0.1		V
$V_{OL}$	Low-level output voltage	I <sub>OL</sub> = 1.6 mA			0.4	V
V	Positive-going input threshold	V <sub>CC</sub> = 3.3 V		1.5	2.4	V
V <sub>IT+</sub>	voltage	V <sub>CC</sub> = 5 V		1.8	2.4	
V	Negative-going input threshold	V <sub>CC</sub> = 3.3 V	0.6	1.2		V
$V_{IT-}$	voltage	V <sub>CC</sub> = 5 V	0.8	1.5		V
V <sub>hys</sub>	Input hysteresis (V <sub>IT+</sub> - V <sub>IT-</sub> )			0.3		V
I <sub>off</sub>	Output leakage current	EN = V <sub>CC</sub>		±0.05	±10	μA
r <sub>i</sub>	Input resistance	$V_1 = \pm 3 \text{ V to } \pm 25 \text{ V}$	3	5	7	kΩ

Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V  $\pm$  0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V  $\pm$  0.5 V. All typical values are at V<sub>CC</sub> = 3.3 V or V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C.

## 6.8 Switching Characteristics: Driver

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>. See Figure 8.

PARAMETER TEST CONDITIONS		MIN	TYP <sup>(2)</sup>	MAX	UNIT		
	Maximum data rate	$C_L$ = 1000 pF, $R_L$ = 3 k $\Omega$ , One DOUT switching, see Figure 3		150	250		kbps
t <sub>sk(p)</sub>	Pulse skew <sup>(3)</sup>	$C_L$ = 150 pF to 2500 pF, $R_L$ = Figure 4	$C_L$ = 150 pF to 2500 pF, $R_L$ = 3 k $\Omega$ to 7 k $\Omega$ , see Figure 4		300		ns
CD(tr)	Slew rate, transition region	$R_L = 3 \text{ k}\Omega \text{ to } 7 \text{ k}\Omega, V_{CC} = 3.3$	C <sub>L</sub> = 150 pF to 1000 pF	6		30	\//uo
SR(tr)	(see Figure 3)	V	C <sub>L</sub> = 150 pF to 2500 pF	4		30	V/µs

Test conditions are C1-C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V  $\pm$  0.3 V; C1 = 0.047  $\mu$ F, C2-C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V  $\pm$  0.5 V.

#### 6.9 Switching Characteristics: Receiver

over operating free-air temperature range (unless otherwise noted)(1). See Figure 8.

	PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(2)</sup>	MAX	UNIT
t <sub>PLH</sub>	Propagation delay time, low- to high-level output	C <sub>L</sub> = 150 pF, see Figure 5		300		ns
t <sub>PHL</sub>	Propagation delay time, high- to low-level output	C <sub>L</sub> = 150 pF, see Figure 5		300		ns
t <sub>en</sub>	Output enable time	$C_L$ = 150 pF, $R_L$ = 3 k $\Omega$ , see Figure 6		200		ns
t <sub>dis</sub>	Output disable time	$C_L$ = 150 pF, $R_L$ = 3 k $\Omega$ , see Figure 6		200		ns
t <sub>sk(p)</sub>	Pulse skew <sup>(3)</sup>	See Figure 5		300		ns

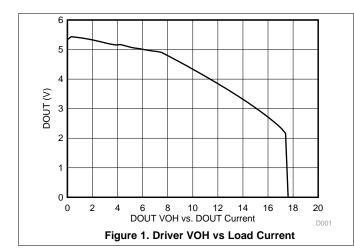
Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V ± 0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V ± 0.5 V. All typical values are at V<sub>CC</sub> = 3.3 V or V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C. Pulse skew is defined as |tPLH – tPHL| of each channel of the same device.

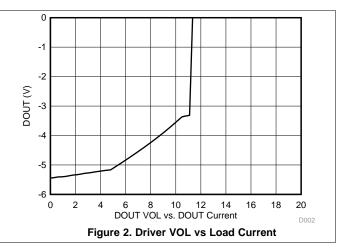
All typical values are at  $V_{CC}=3.3~V$  or  $V_{CC}=5~V$ , and  $T_A=25^{\circ}C$ . Pulse skew is defined as |tPLH - tPHL| of each channel of the same device.



## 6.10 Typical Characteristics

 $T_A = 25^{\circ} \text{ C}; V_{CC} = 3.3 \text{V}$ 

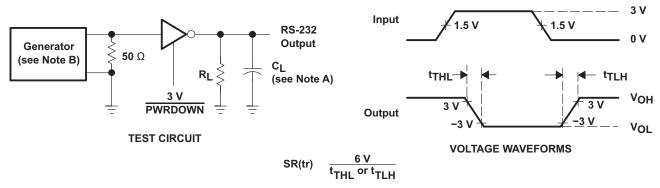




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## TEXAS INSTRUMENTS

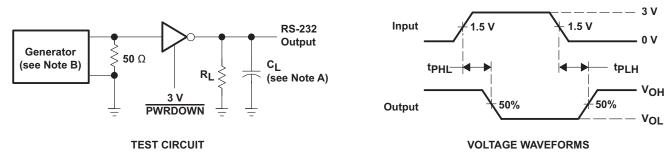
#### 7 Parameter Measurement Information



NOTES: A. CL includes probe and jig capacitance.

B. The pulse generator has the following characteristics: PRR = 250 kbit/s,  $Z_O = 50 \ \Omega$ , 50% duty cycle,  $t_\Gamma \le 10 \ ns$ .

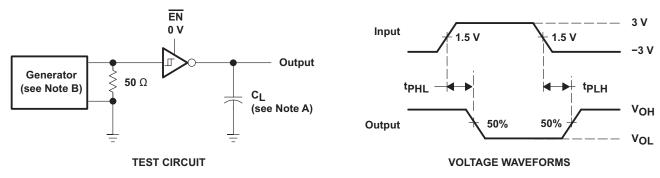
Figure 3. Driver Slew Rate



NOTES: A. C<sub>I</sub> includes probe and jig capacitance.

B. The pulse generator has the following characteristics: PRR = 250 kbit/s,  $Z_O = 50 \Omega$ , 50% duty cycle,  $t_r \le 10$  ns.  $t_f \le 10$  ns.

Figure 4. Driver Pulse Skew



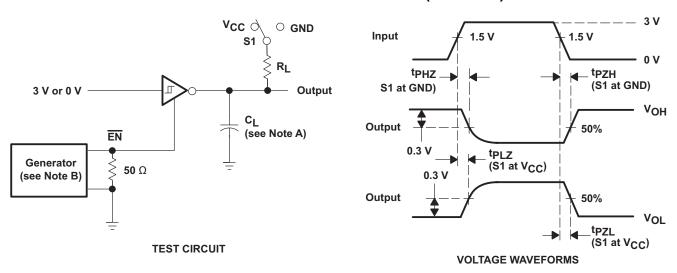
NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

B. The pulse generator has the following characteristics:  $Z_O = 50 \Omega$ , 50% duty cycle,  $t_\Gamma \le 10$  ns,  $t_f \le 10$  ns.

Figure 5. Receiver Propagation Delay Times



## **Parameter Measurement Information (continued)**



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

B. The pulse generator has the following characteristics:  $Z_O = 50 \Omega$ , 50% duty cycle,  $t_r \le 10$  ns,  $t_f \le 10$  ns.

Figure 6. Receiver Enable and Disable Times



#### 8 Detailed Description

#### 8.1 Overview

The MAX3222 consists of two line drivers, two line receivers, and a dual charge-pump circuit with  $\pm 15$ -kV ESD protection pin to pin (serial-port connection pins, including GND). The device meets the requirements of TIA/EIA-232-F and provides the electrical interface between an asynchronous communication controller and the serial-port connector. The charge pump and four small external capacitors allow operation from a single 3-V to 5.5-V supply. The device operates at data signaling rates up to 250 kbit/s and a maximum of 30-V/ $\mu$ s driver output slew rate.

The MAX3222 can be placed in the power-down mode by setting  $\overline{PWRDOWN}$  low, which draws only 1  $\mu A$  from the power supply. When the device is powered down, the receivers remain active while the drivers are placed in the high-impedance state. Also, during power down, the onboard charge pump is disabled; V+ is lowered to  $V_{CC}$ , and V- is raised toward GND. Receiver outputs also can be placed in the high-impedance state by setting EN high.

#### 8.2 Functional Block Diagram

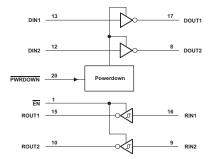


Figure 7. Logic Diagram (Positive Logic)



#### 8.3 Feature Description

#### 8.3.1 Power

The power block increases, inverts, and regulates voltage at V+ and V- pins using a charge pump that requires four external capacitors.

#### 8.3.2 RS232 Driver

Two drivers interface standard logic level to RS232 levels. PWRDOWN input low turns driver off and PWRDOWN input high turns driver on. Both DIN inputs and PWRDOWN input must be valid high or low. Do not float logic input pins.

#### 8.3.3 RS232 Receiver

Two receivers interface RS232 levels to standard logic levels. An open input will result in a high out<u>put</u> on ROUT. Each RIN input includes an internal standard RS232 load. <u>EN</u> input low turns on both ROUT pins. EN input high puts both ROUT pins into high impedance state, output off. <u>EN</u> input must be valid high or low. Do not float logic input pins.

#### 8.4 Device Functional Modes

Driver and receiver outputs are controlled by the functional truth tables.

Table 1. Functional Table - Each Driver (1)

INP	UTS	OUTPUT DOUT				
DIN	PWRDOWN	001701 0001				
X	L	Z				
L	Н	Н				
Н	Н	L				

(1) H = high level, L = low level, X = irrelevant, Z = high impedance

Table 2. Functional Table - Each Receiver (1)

INPL	JTS	OUTDUT DOUT			
RIN	EN	OUTPUT ROUT			
L	L	Н			
Н	L	L			
X	Н	Z			
Open	L	Н			

(1) H = high level, L = low level, X = irrelevant, Z = high impedance (off), Open = input disconnected or connected driver off



## 9 Application and Implementation

#### NOTE

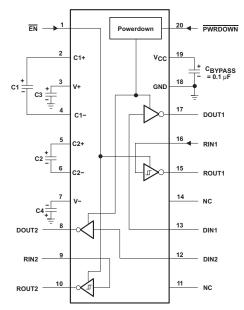
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

## 9.1 Application Information

The MAX3222 interfaces a universal asynchronous receiver / transmitter (UART) to RS-232 port voltage levels. External capacitors are used to generate RS-232 compliant voltages. For proper operation, add capacitors as shown in Figure 8.

## 9.2 Typical Application

ROUT and DIN connect to UART or general purpose logic lines. RIN and DOUT lines connect to a RS232 connector or cable.



C3 can be connected to  $V_{CC}$  or GND.

Resistor values shown are nominal.

NC - No internal connection

Nonpolarized ceramic capacitors are acceptable. If polarized tantalum or electrolytic capacitors are used, they should be connected as shown.

Figure 8. Recommended Application Schematic

## 9.2.1 Design Requirements

- Recommended V<sub>CC</sub> is 3.3 V or 5 V. 3 V to 5.5 V is also possible
- Maximum recommended bit rate is 250 kbit/s.

Table 3. V<sub>CC</sub> vs Capacitor Values

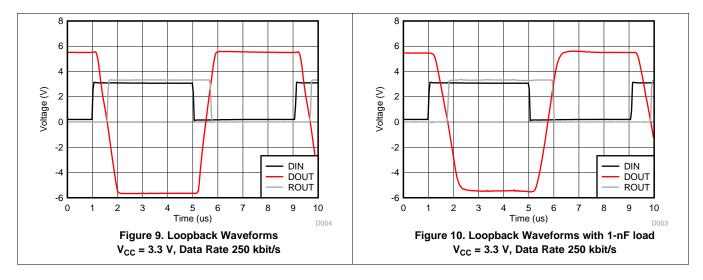
VCC	C1	C2, C3, and C4
3.3 V ± 0.3 V	0.1 μF	0.1 μF
5 V ± 0.5 V	0.047 μF	0.33 μF
3 V ± 5.5 V	0.1 μF	0.47 μF



## 9.2.2 Detailed Design Procedure

- All DIN, PWRDOWN and EN inputs must be connected to valid low or high logic levels.
- Select capacitor values based on VCC level for best performance.

#### 9.2.3 Application Curves



## 10 Power Supply Recommendations

V<sub>CC</sub> should be between 3 V and 5.5 V. Charge pump capacitors should be chosen using table in Table 3.

## 11 Layout

## 11.1 Layout Guidelines

Keep the external capacitor traces short. This is more important on C1 and C2 nodes that have the fastest rise and fall times. Make the impedance from MAX3222 ground pin and circuit board's ground plane as low as possible for best ESD performance. Use wide metal and multiple vias on both sides of ground pin



## 11.2 Layout Example

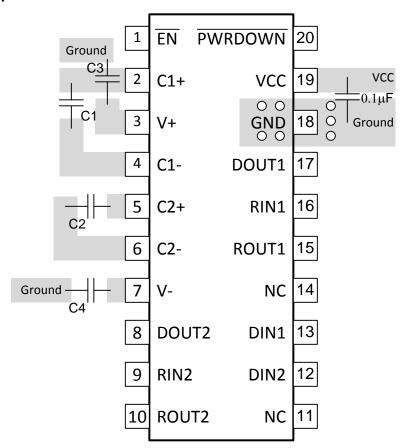


Figure 11. MAX3222 Layout

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#### 12 Device and Documentation Support

#### 12.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 12.2 Community Resources

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**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 12.3 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

#### 12.4 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### 12.5 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

www.ti.com 10-Nov-2025

#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/ MSL rating/		Op temp (°C)	Part marking	
	(1)	(2)			(3)	Ball material	Peak reflow		(6)	
						(4)	(5)			
MAX3222CDB	Obsolete	Production	SSOP (DB)   20	-	-	Call TI	Call TI	0 to 70	MA3222C	
MAX3222CDBR	Obsolete	Production	SSOP (DB)   20	-	-	Call TI	Call TI	0 to 70	MA3222C	
MAX3222CDW	Obsolete	Production	SOIC (DW)   20	-	-	Call TI	Call TI	0 to 70	MAX3222C	
MAX3222CDWR	Obsolete	Production	SOIC (DW)   20	-	-	Call TI	Call TI	0 to 70	MAX3222C	
MAX3222CPWR	Active	Production	TSSOP (PW)   20	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	MA3222C	
MAX3222CPWR.A	Active	Production	TSSOP (PW)   20	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	MA3222C	
MAX3222IDB	Obsolete	Production	SSOP (DB)   20	-	-	Call TI	Call TI	-40 to 85	MB3222I	
MAX3222IDW	Obsolete	Production	SOIC (DW)   20	-	-	Call TI	Call TI	-40 to 85	MAX3222I	
MAX3222IDWR	Obsolete	Production	SOIC (DW)   20	-	-	Call TI	Call TI	-40 to 85	MAX3222I	
MAX3222IPWR	Active	Production	TSSOP (PW)   20	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MB3222I	
MAX3222IPWR.A	Active	Production	TSSOP (PW)   20	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MB3222I	

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.



## **PACKAGE OPTION ADDENDUM**

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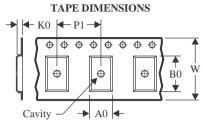
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

## **PACKAGE MATERIALS INFORMATION**

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## TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

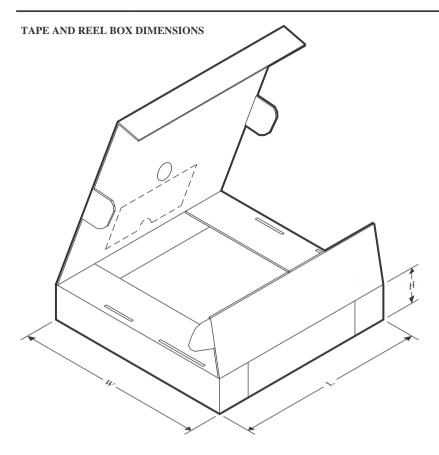


#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
MAX3222CPWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1
MAX3222IPWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1

**PACKAGE MATERIALS INFORMATION** 

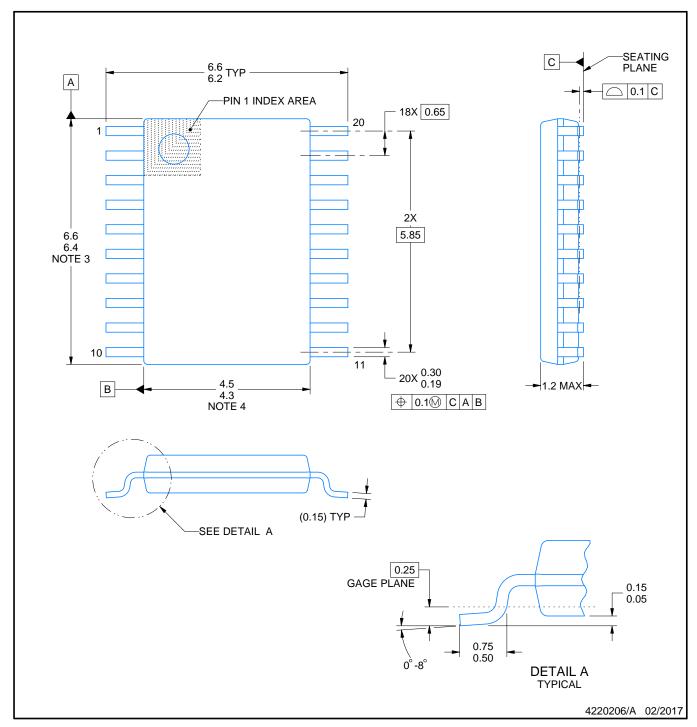
www.ti.com 24-Jul-2025



#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
MAX3222CPWR	TSSOP	PW	20	2000	353.0	353.0	32.0
MAX3222IPWR	TSSOP	PW	20	2000	353.0	353.0	32.0





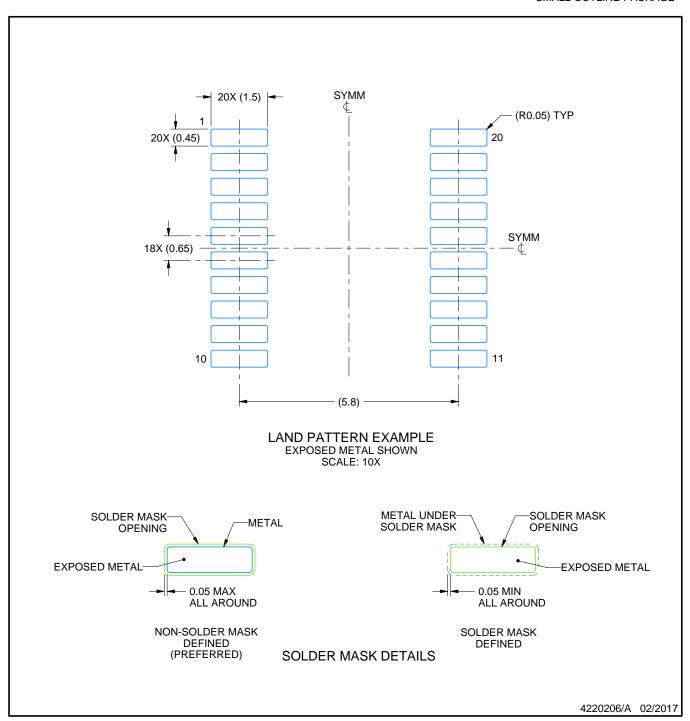
#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



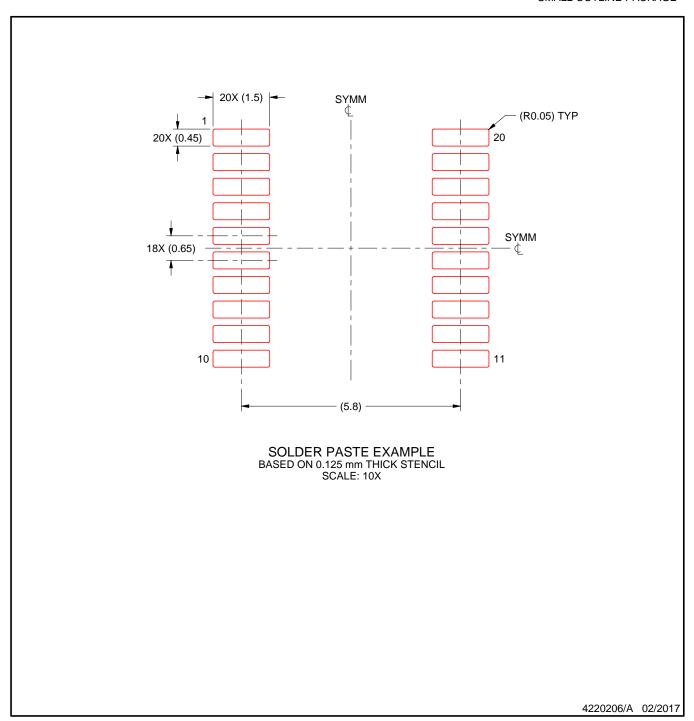


NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





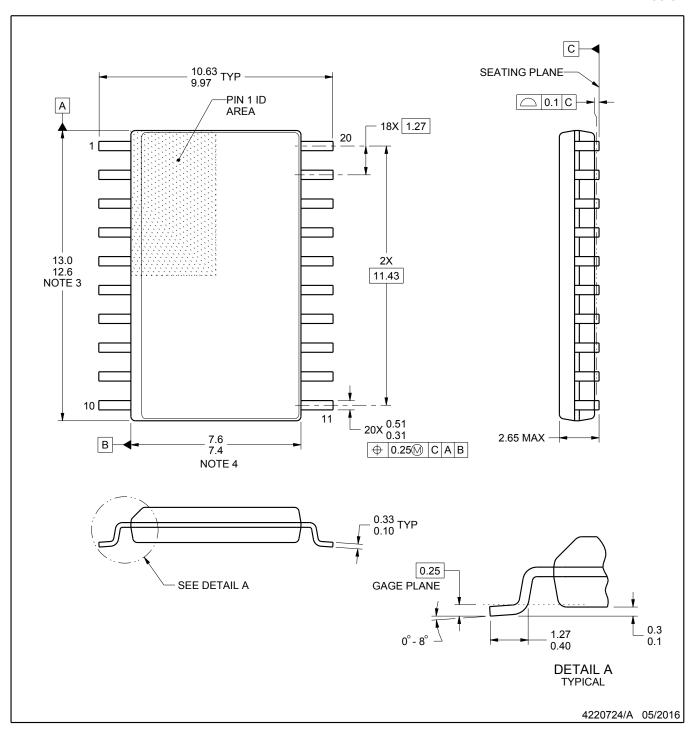
NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.





SOIC



#### NOTES:

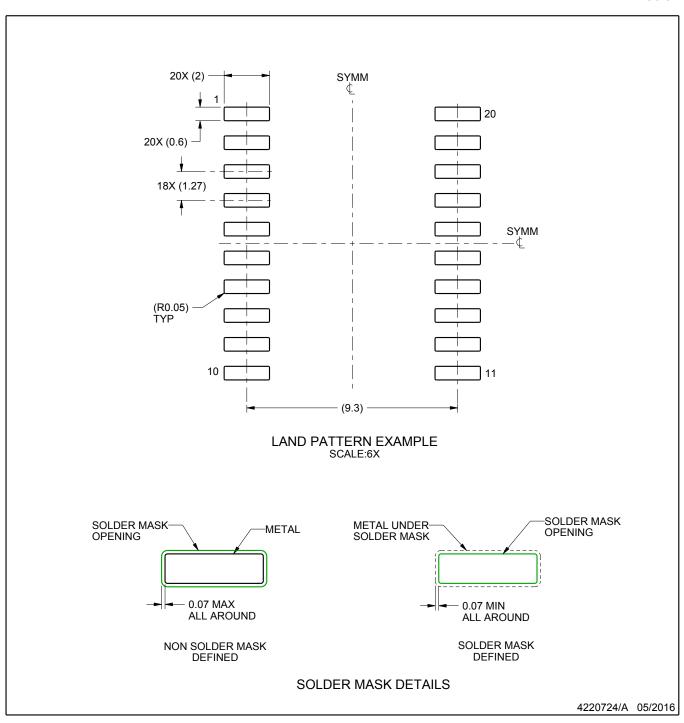
- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



SOIC



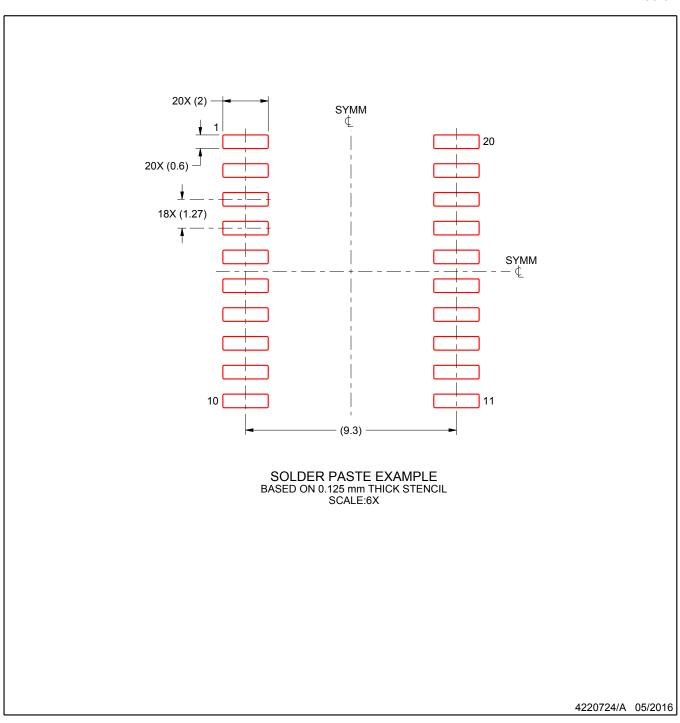
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC

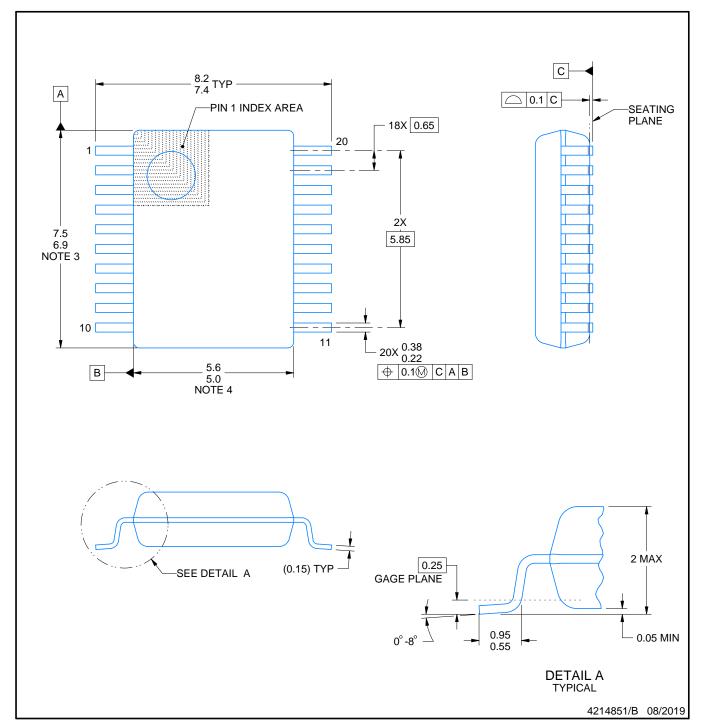


NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







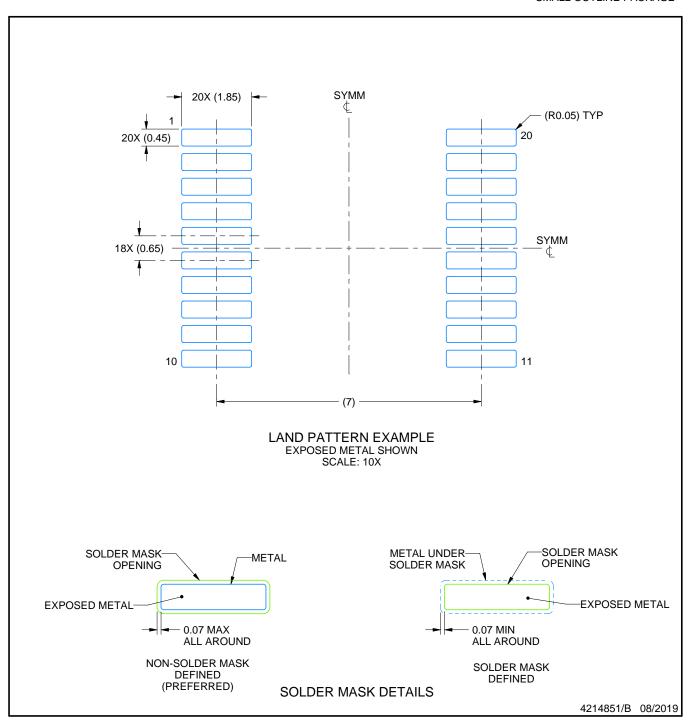
#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-150.



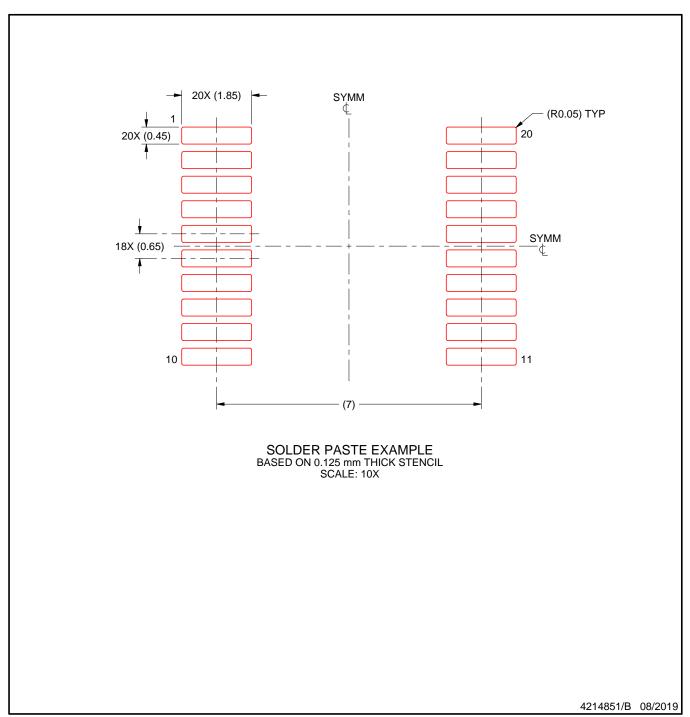


NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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